

## H5N2512CF

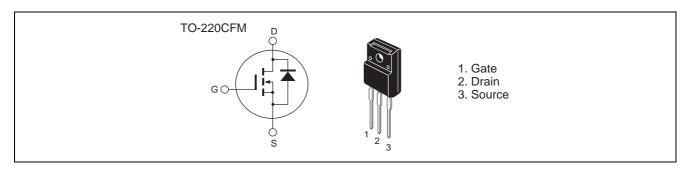
# Silicon N Channel MOS FET High Speed Power Switching

REJ03G0481-0100 Rev.1.00 Nov.26.2004

#### **Features**

- Low on-resistance
- Low leakage current
- High Speed Switching
- Built-in fast recovery diode

#### **Outline**



#### **Absolute Maximum Ratings**

 $(Ta = 25^{\circ}C)$ 

| Symbol                        | Ratings   | Unit   |
|-------------------------------|---|--|
| V <sub>DSS</sub>              | 250   | V  |
| $V_{GSS}$                     | ±30   | V  |
| I <sub>D</sub>                | 18  | A  |
| I <sub>D(pulse)</sub> Note 1  | 72  | Α  |
| I <sub>DR</sub>               | 18  | A  |
| I <sub>DR(pulse)</sub> Note 1 | 72  | A  |
| I <sub>AP</sub> Note 3        | 18  | A  |
| Pch Note 2                    | 35  | W  |
| θch-c                         | 3.57  | °C/W   |
| Tch                           | 150   | °C   |
| Tstg                          | -55 to +150   | °C   |
|                               | V <sub>DSS</sub> V <sub>GSS</sub> I <sub>D</sub> I <sub>D(pulse)</sub> Note 1 I <sub>DR</sub> I <sub>DR(pulse)</sub> Note 1 I <sub>DR</sub> I <sub>DR(pulse)</sub> Note 1 I <sub>AP</sub> Note 3 Pch Note 2 θch-c Tch | VDSS     250       VGSS     ±30       ID     18       ID(pulse)     72       IDR     18       IDR(pulse)     72       IAP     72       IAP     18       Pch Note 3     18       Pch Note 2     35       θch-c     3.57       Tch     150 |

Notes: 1. PW  $\leq$  10  $\mu$ s, duty cycle  $\leq$  1%

2. Value at Tc = 25°C

3. Tch ≤ 150°C

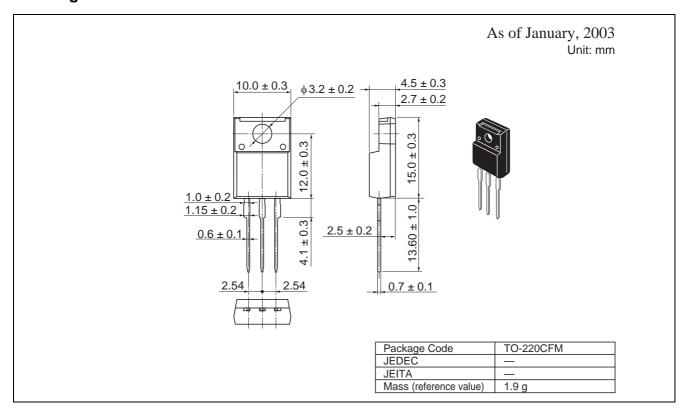
#### **Electrical Characteristics**

 $(Ta = 25^{\circ}C)$ 

| Item                                       | Symbol               | Min | Тур   | Max   | Unit | Test Conditions  |
|--|----------------------|-----|-------|-------|------|--|
| Drain to source breakdown voltage          | $V_{(BR)DSS}$        | 250 | _     | _     | V    | $I_D = 10 \text{ mA}, V_{GS} = 0$                            |
| Gate to source leak current                | I <sub>GSS</sub>     | _   | _     | ±0.1  | μΑ   | $V_{GS} = \pm 30 \text{ V}, V_{DS} = 0$                      |
| Zero gate voltage drain current            | I <sub>DSS</sub>     | _   | _     | 10    | μΑ   | $V_{DS} = 250 \text{ V}, V_{GS} = 0$                         |
| Gate to source cutoff voltage              | V <sub>GS(off)</sub> | 1.5 | _     | 4.0   | V    | $I_D = 1 \text{ mA}, V_{DS} = 10 \text{ V}$                  |
| Static drain to source on state resistance | R <sub>DS(on)</sub>  | _   | 0.082 | 0.105 | Ω    | $I_D = 9 \text{ A}, V_{GS} = 10 \text{ V}^{\text{Note 4}}$   |
| Forward transfer admittance                | y <sub>fs</sub>      | 9   | 16    | _     | S    | $I_D = 9 \text{ A}, V_{DS} = 10 \text{ V}^{\text{Note 4}}$   |
| Input capacitance                          | Ciss                 | _   | 2200  | _     | pF   | V <sub>DS</sub> = 25 V                                       |
| Output capacitance                         | Coss                 | _   | 300   | _     | pF   | V <sub>GS</sub> = 0<br>f = 1MHz                              |
| Reverse transfer capacitance               | Crss                 | _   | 85    | _     | pF   |  |
| Turn-on delay time                         | t <sub>d(on)</sub>   | _   | 32    | _     | ns   | I <sub>D</sub> = 9 A   |
| Rise time                                  | t <sub>r</sub>       | _   | 60    | _     | ns   | $R_L = 13.9 \Omega$  |
| Turn-off delay time                        | $t_{d(off)}$         | _   | 160   | _     | ns   | $V_{GS} = 10 \text{ V}$                                      |
| Fall time                                  | t <sub>f</sub>       | _   | 60    | _     | ns   | $R_g = 10 \Omega$  |
| Total gate charge                          | Qg                   | _   | 81    | _     | nC   | V <sub>DD</sub> = 200 V                                      |
| Gate to source charge                      | Qgs                  | _   | 10    | _     | nC   | V <sub>GS</sub> = 10 V<br>I <sub>D</sub> = 18 A              |
| Gate to drain charge                       | Qgd                  | _   | 38    | _     | nC   |  |
| Body-drain diode forward voltage           | $V_{DF}$             | _   | 0.9   | 1.4   | V    | $I_F = 18 \text{ A}, V_{GS} = 0$ Note4                       |
| Body–drain diode reverse recovery time     | t <sub>rr</sub>      | _   | 110   | _     | ns   | $I_F = 18 \text{ A}, V_{GS} = 0$<br>diF/ dt = 100 A/ $\mu$ s |
| Body–drain diode reverse recovery time     | Qrr                  | _   | 0.39  | _     | μС   |  |

Notes: 4. Pulse test

#### **Package Dimensions**



### **Ordering Information**

| Part Name | Quantity | Shipping Container |
|-----------|----------|--------------------|
| H5N3007CF | 50       | Stick              |

Note: Therefore especially small contact area of terminal, miss contact may occur if inadequate soldering condition is applied.

Contact Renesas sales office for any question regarding recommended soldering condition of Renesas.

Renesas Technology Corp. Sales Strategic Planning Div. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan

Keep safety first in your circuit designs!

1. Renesas Technology Corp. puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.

Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of nonflammable material or (iii) prevention against any malfunction or mishap.

- Notes regarding these materials

  1. These materials are intended as a reference to assist our customers in the selection of the Renesas Technology Corp. product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Renesas Technology Corp. a third party.

  2. Renesas Technology Corp. assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials, and are subject to change by Renesas Technology Corp. without notice due to product improvements or other reasons. It is therefore recommended that customers contact Renesas Technology Corp. or an authorized Renesas Technology Corp. product distributor for the latest product information before purchasing a product listed herein.

  The information described here may contain technical inaccuracies or typographical errors.

  Renesas Technology Corp. assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.

  Please also pay attention to information published by Renesas Technology Corp. by various means, including the Renesas Technology Corp. Semiconductor home page (http://www.renesas.com).

  4. When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Renesas Technology Corp. assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.

  5. Renesas Technology Corp. semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Renesas Technology Corp. or an authorized Renesas Technology

- use.

  6. The prior written approval of Renesas Technology Corp. is necessary to reprint or reproduce in whole or in part these materials.

  7. If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.

  Any diversion or reexport contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.

  8. Please contact Renesas Technology Corp. for further details on these materials or the products contained therein.



Refer to "http://www.renesas.com/en/network" for the latest and detailed information.

**RENESAS SALES OFFICES** 

**Renesas Technology America, Inc.** 450 Holger Way, San Jose, CA 95134-1368, U.S.A Tel: <1> (408) 382-7500, Fax: <1> (408) 382-7501

Renesas Technology Europe Limited
Dukes Meadow, Millboard Road, Bourne End, Buckinghamshire, SL8 5FH, U.K. Tel: <44> (1628) 585-100, Fax: <44> (1628) 585-900

Renesas Technology Hong Kong Ltd.
7th Floor, North Tower, World Finance Centre, Harbour City, 1 Canton Road, Tsimshatsui, Kowloon, Hong Kong Tel: <852> 2265-6688, Fax: <852> 2730-6071

**Renesas Technology Taiwan Co., Ltd.** 10th Floor, No.99, Fushing North Road, Taipei, Taiwan Tel: <886> (2) 2715-2888, Fax: <886> (2) 2713-2999

Renesas Technology (Shanghai) Co., Ltd. Unit2607 Ruijing Building, No.205 Maoming Road (S), Shanghai 200020, China Tel: <86> (21) 6472-1001, Fax: <86> (21) 6415-2952

Renesas Technology Singapore Pte. Ltd.
1 Harbour Front Avenue, #06-10, Keppel Bay Tower, Singapore 098632 Tel: <65> 6213-0200, Fax: <65> 6278-8001

http://www.renesas.com